

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant:

Hou, et al.

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**TBD** 

For:

Method of Forming a Contact on a Silicon-on-Insulator Wafer

## Certificate of Mailing via First Class Mail (37 C.F.R. § 1.8(a))

Date of Deposit:

November 24, 2003

I hereby certify that the below listed correspondence is being deposited with the United States Postal Service on the date indicated above as first class mail in an envelope addressed to: Commissioner for Patents, P. O. Box 1450, Alexandria, VA 22313-1450.

Certificate of Mailing via First Class Mail (1 page) Preliminary Amendment (3 pages) Drawings-Replacement Sheets (3 pages) Return Postcard

Respectfully submitted,

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